

## IXTP2N80-VB Datasheet **Power MOSFET**

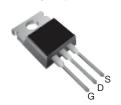
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	850				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	2.7			
Q <sub>g</sub> (Max.) (nC)	78				
Q <sub>gs</sub> (nC)	9.6				
Q <sub>gd</sub> (nC)	45				
Configuration	Single				

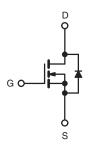
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 **Definition**
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC









N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	850	V	
Gate-Source Voltage			$V_{GS}$	± 20	7 v	
Continuous Drain Current		T <sub>C</sub> = 25 °C		4.1		
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	2.6	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	16		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	260	mJ	
Avalanche Current <sup>a</sup>			I <sub>AR</sub>	4.1	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	13	mJ	
Maximum Power Dissipation T <sub>C</sub> = 25 °C			$P_{D}$	125	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>		
Mounting Toyaus	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=50~V$ , starting  $T_J=25~^{\circ}C$ , L=29~mH,  $R_g=25~\Omega$ ,  $I_{AS}=4.1~A$  (see fig. 12). c.  $I_{SD}\leq4.1~A$ ,  $dI/dt\leq100~A/\mu s$ ,  $V_{DD}\leq600~V$ ,  $T_J\leq150~^{\circ}C$ . d. 1.6 mm from case.

服务热线:400-655-8788

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	62	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	-	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	1.0	

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 250 μA	850	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.90	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$		-	4.0	V
Gate-Source Leakage	$I_{GSS}$	,	V <sub>GS</sub> = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 640 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	100 500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.5 A <sup>b</sup>	_	2.7	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	: 100 V, I <sub>D</sub> = 2.5 A	2.5	-	-	S
Dynamic		·		1			
Input Capacitance	C <sub>iss</sub>		V 0 V	-	1300	-	
Output Capacitance	C <sub>oss</sub>	1	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. } 5$		310	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.			190	-	
Total Gate Charge	Qg			-	-	78	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 4.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	9.6	
Gate-Drain Charge	$Q_{gd}$		oss ligi s alia is	-	-	45	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 400 V, $I_{D}$ = 4.1 A, $R_{g}$ = 12 $\Omega$ , $R_{D}$ = 95 $\Omega$ , see fig. 10 <sup>b</sup>		-	12	-	- ns
Rise Time	t <sub>r</sub>			-	33	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	82	-	
Fall Time	t <sub>f</sub>				30	-	
Internal Drain Inductance	$L_D$	6 mm (0.25") t	Between lead, 6 mm (0.25") from		4.5	-	nH
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	
<b>Drain-Source Body Diode Characteristic</b>	es						
Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the	MOSFET symbol showing the		-	4.1	Α
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	16	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C	, I <sub>S</sub> = 4.1 A, V <sub>GS</sub> = 0 V <sup>b</sup>	-	=	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 4.1 A, dI/dt = 100 A/µs <sup>b</sup>		-	480	720	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.8	2.7	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					L <sub>D</sub> )

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

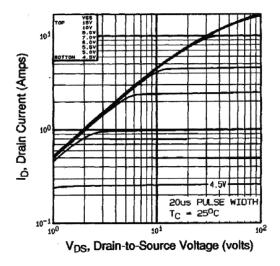


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

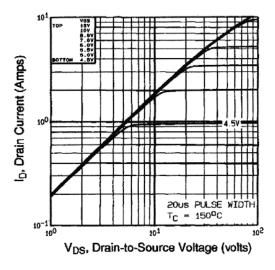


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

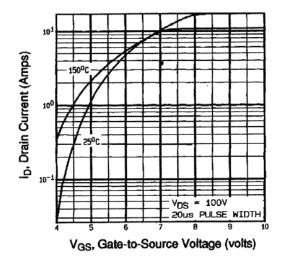


Fig. 3 - Typical Transfer Characteristics

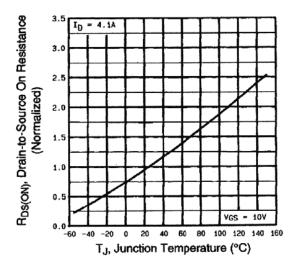


Fig. 4 - Normalized On-Resistance vs. Temperature



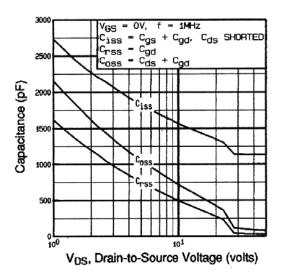


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

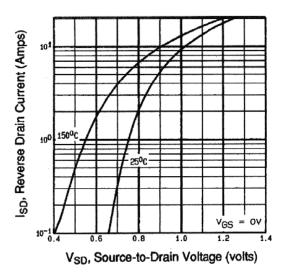


Fig. 7 - Typical Source-Drain Diode Forward Voltage

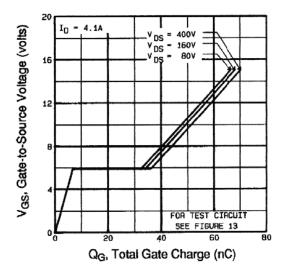


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

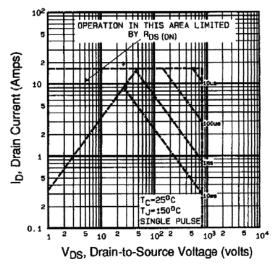


Fig. 8 - Maximum Safe Operating Area



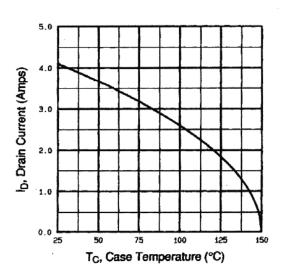


Fig. 9 - Maximum Drain Current vs. Case Temperature

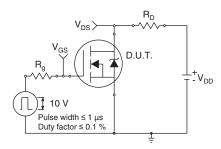


Fig. 10a - Switching Time Test Circuit

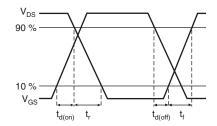


Fig. 10b - Switching Time Waveforms

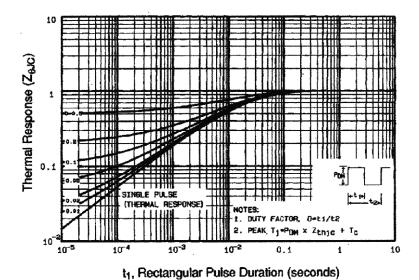


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

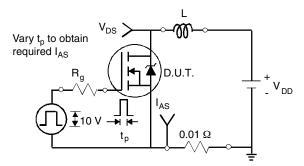


Fig. 12a - Unclamped Inductive Test Circuit

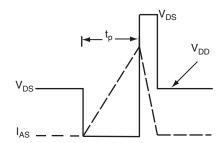


Fig. 12b - Unclamped Inductive Waveforms



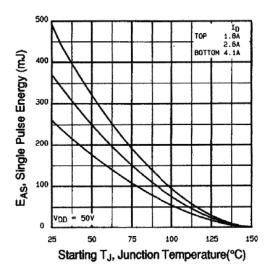


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

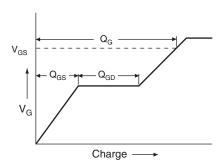


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

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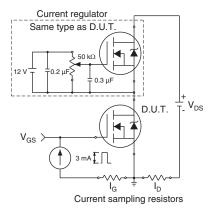
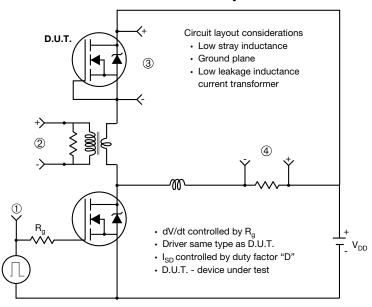


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



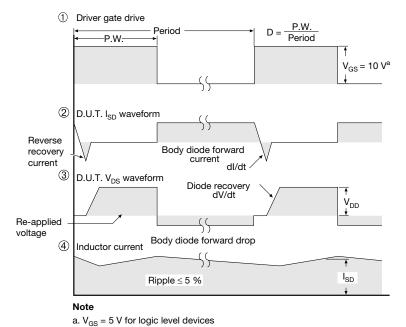
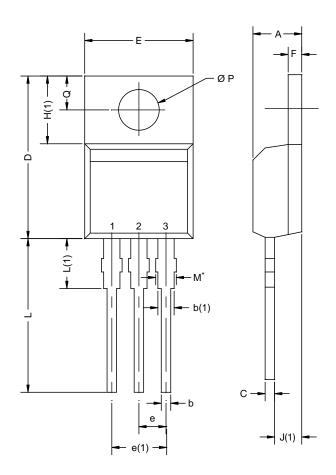


Fig. 14 - For N-Channel



### **TO-220AB**



	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØР	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12-0208-Rev. N, 08-Oct-12						

DWG: 5471

#### Notes

 $<sup>^{\</sup>star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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